

## GL Silicon N-Channel Power MOSFET

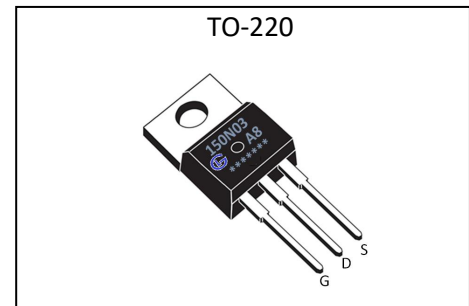
### General Description

The GL150N03A8 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications. The package form is TO-220, which accords with the RoHS standard.

|                  |      |    |
|------------------|------|----|
| $V_{DSS}$        | 30   | V  |
| $I_D$            | 150  | A  |
| $P_D$            | 130  | W  |
| $R_{DS(ON)type}$ | 2.25 | mΩ |

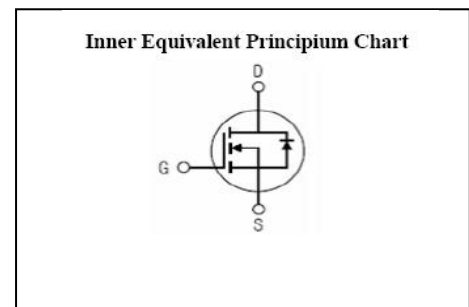
### Features

- $R_{DS(ON)} < 3.0m\Omega$  @  $V_{GS}=10V$  (Typ2.25mΩ)
- High density cell design for ultra low  $R_{dson}$
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation



### Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



### Absolute (Tc=25°C unless otherwise specified)

| Symbol         | Parameter                                        | Rating          | Units |
|----------------|--------------------------------------------------|-----------------|-------|
| $V_{DSS}$      | Drain-to-Source Voltage                          | 30              | V     |
| $I_D$          | Continuous Drain Current( $T_C=25^\circ C$ )     | 150             | A     |
|                | Continuous Drain Current( $T_C=100^\circ C$ )    | 110             | A     |
| $I_{DM}$       | Pulsed Drain Current                             | 600             | A     |
| $V_{GS}$       | Gate-to-Source Voltage                           | $\pm 20$        | V     |
| $P_D$          | Power Dissipation                                | 130             | W     |
| $E_{AS}$       | Single pulse avalanche energy <sup>a5</sup>      | 1800            | mJ    |
| $T_J, T_{stg}$ | Operating Junction and Storage Temperature Range | 175, -55 to 175 | °C    |

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device



# GL150N03A8

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**Electrical Characteristics** (Tc=25°C unless otherwise specified)

| OFF Characteristics |                                   |                                                                   |        |      |      |       |
|---------------------|-----------------------------------|-------------------------------------------------------------------|--------|------|------|-------|
| Symbol              | Parameter                         | Test Conditions                                                   | Rating |      |      | Units |
|                     |                                   |                                                                   | Min.   | Typ. | Max. |       |
| V <sub>DSS</sub>    | Drain to Source Breakdown Voltage | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                        | 30     | --   | --   | V     |
| I <sub>DSS</sub>    | Drain to Source Leakage Current   | V <sub>DS</sub> =30V, V <sub>GS</sub> = 0V, T <sub>a</sub> = 25°C | --     | --   | 1.0  | μA    |
| I <sub>GSS(F)</sub> | Gate to Source Forward Leakage    | V <sub>GS</sub> = +20V                                            | --     | --   | 0.1  | μA    |
| I <sub>GSS(R)</sub> | Gate to Source Reverse Leakage    | V <sub>GS</sub> = -20V                                            | --     | --   | -0.1 | μA    |

| ON Characteristics <sup>a3</sup> |                               |                                                          |        |      |      |       |
|----------------------------------|-------------------------------|----------------------------------------------------------|--------|------|------|-------|
| Symbol                           | Parameter                     | Test Conditions                                          | Rating |      |      | Units |
|                                  |                               |                                                          | Min.   | Typ. | Max. |       |
| R <sub>DS(ON)</sub>              | Drain-to-Source On-Resistance | V <sub>GS</sub> =10V, I <sub>D</sub> =25A                | --     | 2.25 | 3.0  | mΩ    |
| V <sub>GS(TH)</sub>              | Gate Threshold Voltage        | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA | 1.0    | 1.6  | 3.0  | V     |
| Pulse width tp≤380μs, δ≤2%       |                               |                                                          |        |      |      |       |

| Dynamic Characteristics <sup>a4</sup> |                              |                                                    |        |      |      |       |
|---------------------------------------|------------------------------|----------------------------------------------------|--------|------|------|-------|
| Symbol                                | Parameter                    | Test Conditions                                    | Rating |      |      | Units |
|                                       |                              |                                                    | Min.   | Typ. | Max. |       |
| g <sub>fs</sub>                       | Forward Transconductance     | V <sub>DS</sub> =5V, I <sub>D</sub> =25A           | 30     | --   | --   | S     |
| C <sub>iss</sub>                      | Input Capacitance            | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V f=1.0MHz | --     | 5000 | --   | pF    |
| C <sub>oss</sub>                      | Output Capacitance           |                                                    | --     | 1150 | --   |       |
| C <sub>rss</sub>                      | Reverse Transfer Capacitance |                                                    | --     | 580  | --   |       |

| Resistive Switching Characteristics <sup>a4</sup> |                                   |                                                                                         |        |      |      |       |
|---------------------------------------------------|-----------------------------------|-----------------------------------------------------------------------------------------|--------|------|------|-------|
| Symbol                                            | Parameter                         | Test Conditions                                                                         | Rating |      |      | Units |
|                                                   |                                   |                                                                                         | Min.   | Typ. | Max. |       |
| t <sub>d(ON)</sub>                                | Turn-on Delay Time                | V <sub>DD</sub> =15V, I <sub>D</sub> =25A<br>V <sub>GS</sub> =10V, R <sub>G</sub> =1.8Ω | --     | 26   | --   | ns    |
| t <sub>r</sub>                                    | Rise Time                         |                                                                                         | --     | 24   | --   |       |
| t <sub>d(OFF)</sub>                               | Turn-Off Delay Time               |                                                                                         | --     | 95   | --   |       |
| t <sub>f</sub>                                    | Fall Time                         |                                                                                         | --     | 40   | --   |       |
| Q <sub>g</sub>                                    | Total Gate Charge                 | V <sub>DD</sub> =15V, I <sub>D</sub> =25A<br>V <sub>GS</sub> =10V                       | --     | 35   | --   | nC    |
| Q <sub>gs</sub>                                   | Gate to Source Charge             |                                                                                         | --     | 8    | --   |       |
| Q <sub>gd</sub>                                   | Gate to Drain ( "Miller" ) Charge |                                                                                         | --     | 13   | --   |       |



# GL150N03A8

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### Source-Drain Diode Characteristics

| Symbol   | Parameter                                            | Test Conditions       | Rating |      |      | Units |
|----------|------------------------------------------------------|-----------------------|--------|------|------|-------|
|          |                                                      |                       | Min.   | Typ. | Max. |       |
| $I_S$    | Continuous Source Current <sup>a2</sup> (Body Diode) |                       | --     | --   | 150  | A     |
| $V_{SD}$ | Diode Forward Voltage <sup>a3</sup>                  | $I_S=150A, V_{GS}=0V$ | --     | --   | 1.2  | V     |

### Thermal Characteristics

| Symbol          | Parameter                      | Typ. | Units |
|-----------------|--------------------------------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case <sup>a2</sup> | 1.15 | °C/W  |

a<sup>1</sup>: Repetitive Rating: Pulse width limited by maximum junction temperature.

a<sup>2</sup>: Surface Mounted on FR4 Board,  $t \leq 10\text{sec}$ .

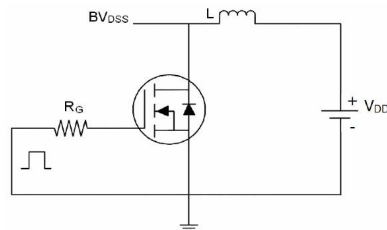
a<sup>3</sup>: Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

a<sup>4</sup>: Guaranteed by design, not subject to production

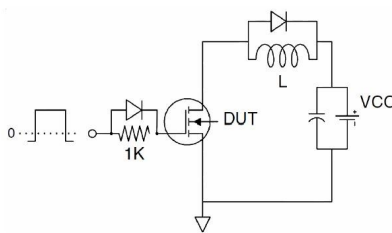
a<sup>5</sup>:  $E_{AS}$  condition:  $T_j=25^\circ\text{C}, V_{DD}=15V, V_{GS}=10V, L=1.0\text{mH}, R_g=25\Omega$

### Test Circuits

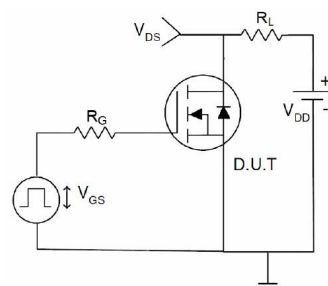
#### 1) $E_{AS}$ test Circuits



#### 2) Gate charge test Circuit:



#### 3) Switch Time Test Circuit:



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### Characteristics Curves

Typical Electrical and Thermal Characteristics (Curves)

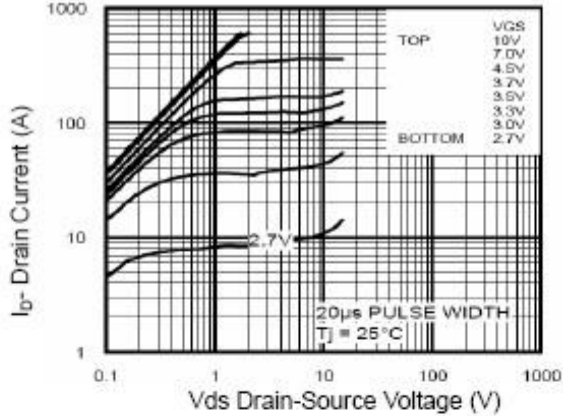


Figure 1 Output Characteristics

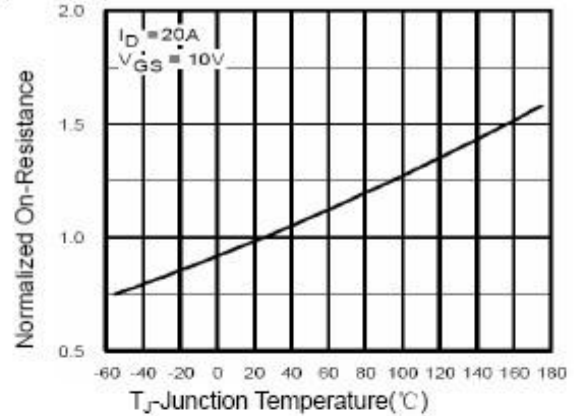


Figure 4 Rdson-Junction Temperature

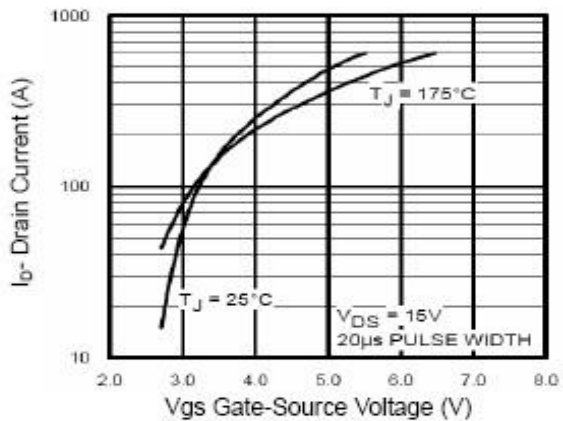


Figure 2 Transfer Characteristics

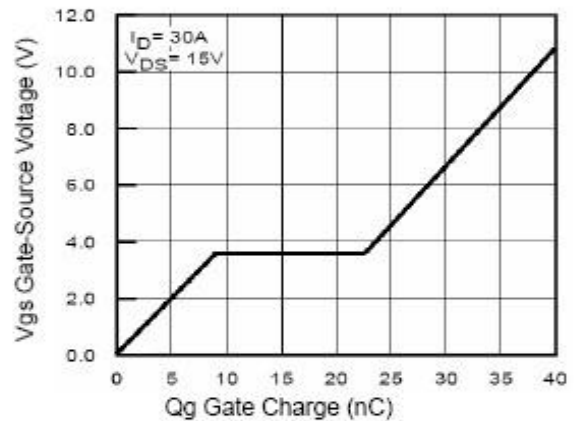


Figure 5 Gate Charge

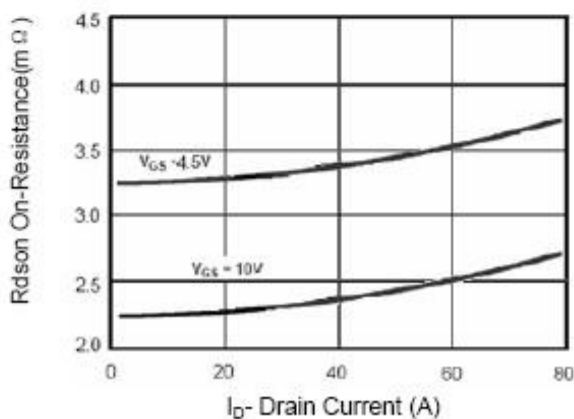


Figure 3 Rdson- Drain Current

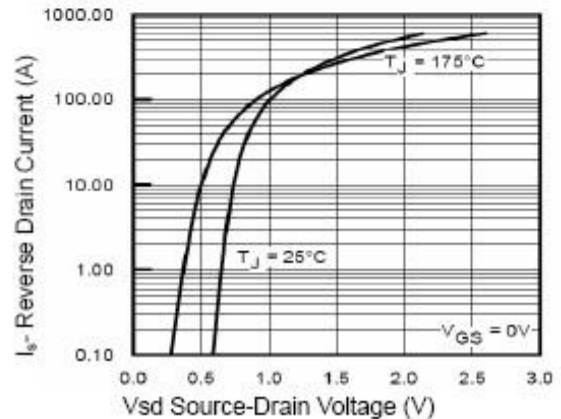


Figure 6 Source- Drain Diode Forward

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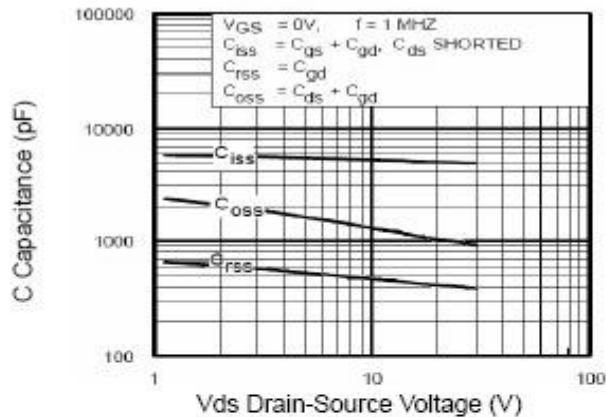


Figure 7 Capacitance vs  $V_{ds}$

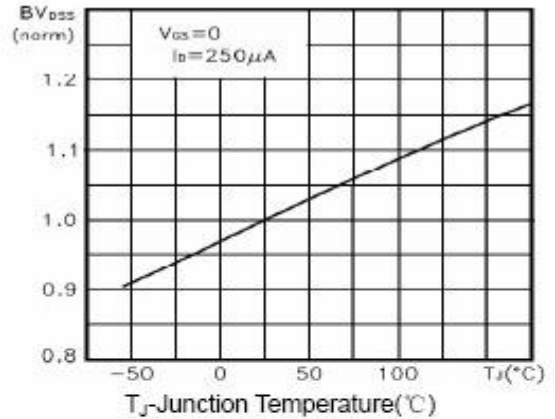


Figure 9  $BV_{DSS}$  vs Junction Temperature

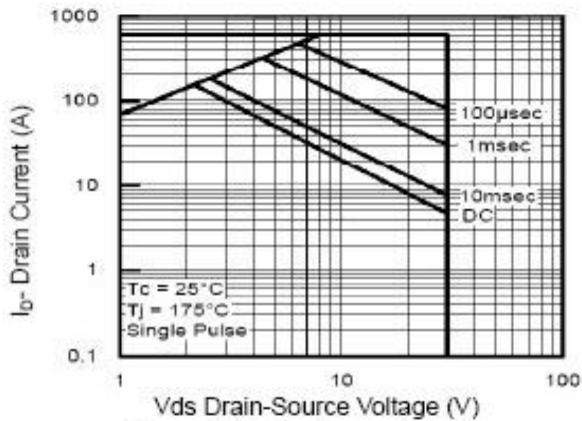


Figure 8 Safe Operation Area

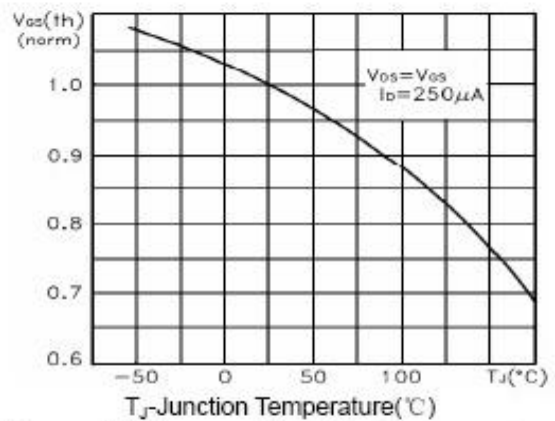


Figure 10  $V_{GS(th)}$  vs Junction Temperature

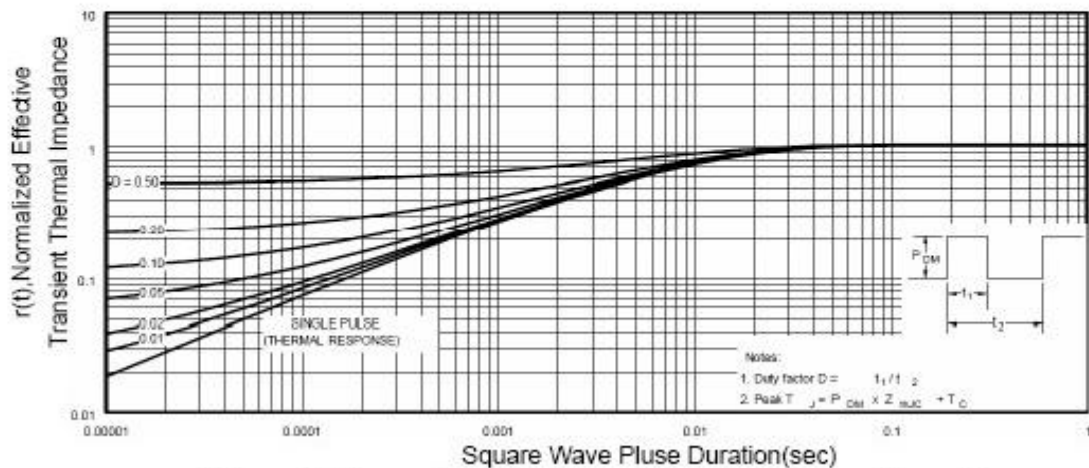


Figure 11 Normalized Maximum Transient Thermal Impedance